

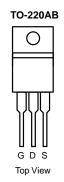
FQP2P25-VB Datasheet

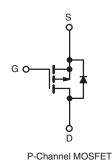
Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 250			
R _{DS(on)} (Ω)	V _{GS} = - 10 V	1.0		
Q _g (Max.) (nC)	38			
Q _{gs} (nC)	8.0			
Q _{gd} (nC)	18			
Configuration	Single			

FEATURES

- Advanced Process Technology
- Dynamic dV/dt Rating
- 150 °C Operating Temperature
- · Fast Switching
- P-Channel
- Fully Avalanche Rated
- Lead (Pb)-free Available





ABSOLUTE MAXIMUM RATINGS $T_C = 25 \text{ °C}$, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	- 250	v	
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	V _{GS} at - 10 V T _C =	T _C = 25 °C	Ι _D	- 6.0		
		T _C = 100 °C		- 4.0	A	
Pulsed Drain Current ^a			I _{DM}	- 16		
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	520	mJ	
Repetitive Avalanche Current ^a			I _{AR}	- 4.1	А	
Repetitive Avalanche Energy ^a			E _{AR}	3.5	mJ	
Maximum Power Dissipation	T _C = 25 °C		PD	85	W	
Peak Diode Recovery dV/dt ^c			dV/dt	- 5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	Э°	
Soldering Recommendations (Peak Temperature)	for ⁻	10 s		300 ^d	U	
Mounting Targue	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T_J = 25 °C, L = 62 mH, R_G = 25 Ω , I_{AS} = - 4.1 A (see fig. 12). c. I_{SD} \leq - 4.1 A, dl/dt \leq - 640 A/µs, V_{DD} \leq V_{DS}, T_J \leq 150 °C. d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply



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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.6	C/W	

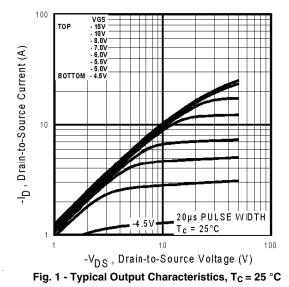
PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	- 250	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, $I_D = 1 \text{ mA}$		- 0.27	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$		-	- 4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Zarra Casta Malta na Ducin Carrant	Current $I_{DSS} = -250 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ $V_{DS} = -200 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 150 ^{\circ}\text{C}$	$V_{DS} = -250 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	- 25	μA
Zero Gate Voltage Drain Current		V, V _{GS} = 0 V, T _J = 150 °C	-	-	- 250		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 2.5 A ^b	-	1.0	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} = - 50 V, I _D = - 4.1 A ^b		2.2	-	-	S
Dynamic						•	
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = -25 V,$ f = 1.0 MHz, see fig. 5		-	680	-	pF
Output Capacitance	C _{oss}			-	170	-	
Reverse Transfer Capacitance	C _{rss}			-	40	-	
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	1
Total Gate Charge	Qg			-	-	38	
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V	$V_{GS} = -10 V$ $I_D = -4.1 A, V_{DS} = -200 V,$ see fig. 6 and 13 ^b	-	-	8.0	nC
Gate-Drain Charge	Q _{gd}			-	-	18	
Turn-On Delay Time	t _{d(on)}			-	12	-	
Rise Time	t _r	$\label{eq:VDD} \begin{array}{l} V_{DD} = - \ 130 \ V, \ I_D = - \ 4.1 \ A, \\ R_G = 12 \ \Omega, \ R_D = 31 \ \Omega, \\ \text{see fig. } 10^b \end{array}$		-	23	-	ns
Turn-Off Delay Time	t _{d(off)}			-	34	-	
Fall Time	t _f			-	21	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH
Internal Source Inductance	L _S			-	7.5	-	
Drain-Source Body Diode Characteristic	S						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 4.1	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 16	
Body Diode Voltage	V_{SD}	$T_J = 25 \ ^{\circ}C, I_S = -4.1 \ A, V_{GS} = 0 \ V^b$		-	-	- 6.5	V
Body Diode Reverse Recovery Time	t _{rr}	- $T_J = 25 \text{ °C}, I_F = -4.1 \text{ A}, dl/dt = -100 \text{ A}/\mu s^b$		-	190	290	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.5	2.2	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					∟ _D)

Notes

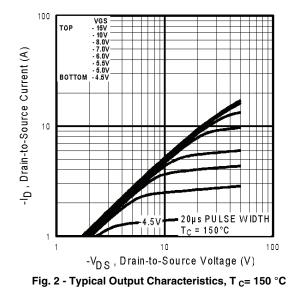
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

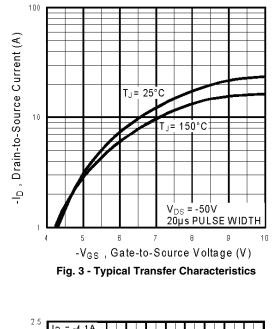
b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.











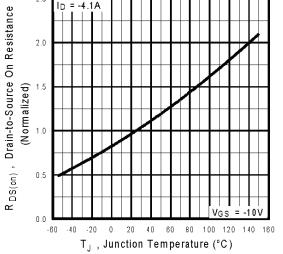


Fig. 4 - Normalized On-Resistance vs. Temperature

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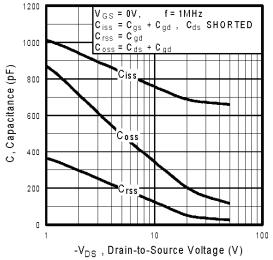


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

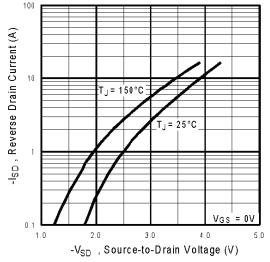


Fig. 7 - Typical Source-Drain Diode Forward Voltage

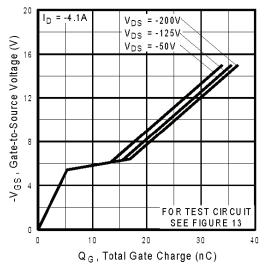


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

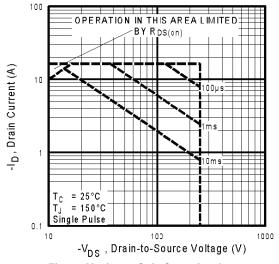


Fig. 8 - Maximum Safe Operating Area

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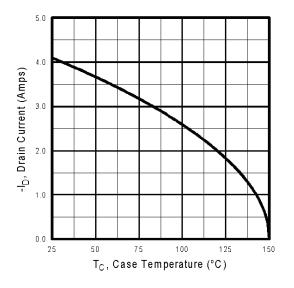


Fig. 9 - Maximum Drain Current vs. Case Temperature

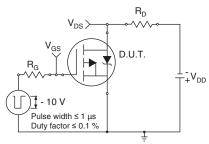


Fig. 10a - Switching Time Test Circuit

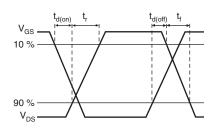


Fig. 10b - Switching Time Waveforms

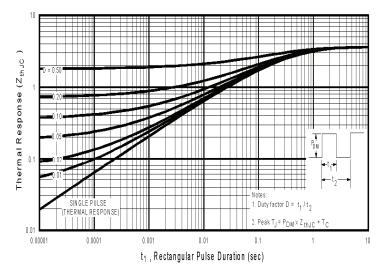


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

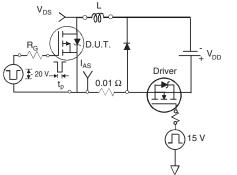


Fig. 12a - Unclamped Inductive Test Circuit

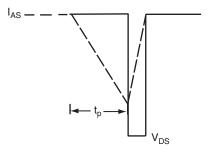


Fig. 12b - Unclamped Inductive Waveforms



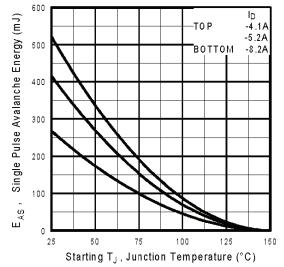


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

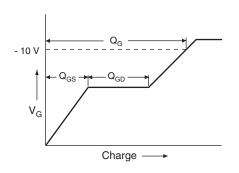


Fig. 13a - Basic Gate Charge Waveform

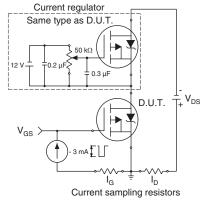
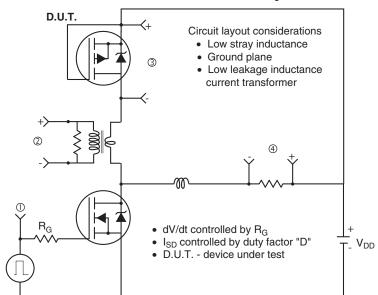


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit

• Compliment N-Channel of D.U.T. for driver

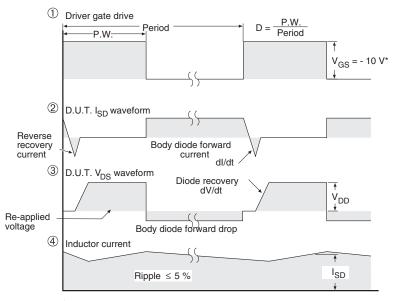




Fig. 14 - For P-Channel



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